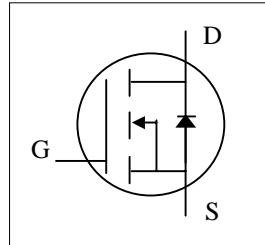
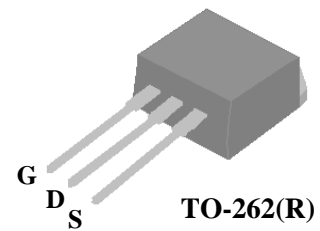




- ▼ 100% R_g & UIS Test
- ▼ Low t_{rr} / Q_{rr}
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant & Halogen-Free



BV _{DSS}	600V
R _{DS(ON)}	115mΩ
I _D ³	28A



Description

AP60SL115D series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The TO-262 package is widely preferred for commercial-industrial through-hole applications and suited for low voltage applications such as DC/DC converters.

Absolute Maximum Ratings @T_j=25°C (unless otherwise specified)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	600	V
V _{GS}	Gate-Source Voltage	+20	V
V _{GS}	Gate-Source Voltage, AC (f > 1Hz)	+30	V
I _D @T _C =25°C	Drain Current, V _{GS} @ 10V ³	28	A
I _D @T _C =100°C	Drain Current, V _{GS} @ 10V ³	17.7	A
I _{DM}	Pulsed Drain Current ¹	84	A
dv/dt	MOSFET dv/dt Ruggedness (V _{DS} = 0 ... 480V)	20	V/ns
P _D @T _C =25°C	Total Power Dissipation	178	W
P _D @T _A =25°C	Total Power Dissipation	2	W
E _{AS}	Single Pulse Avalanche Energy ⁴	300	mJ
dv/dt	Peak Diode Recovery dv/dt ⁵	15	V/ns
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Value	Units
R _{thj-c}	Maximum Thermal Resistance, Junction-case	0.7	°C/W
R _{thj-a}	Maximum Thermal Resistance, Junction-ambient	62	°C/W



AP60SL115DR

Electrical Characteristics @ $T_j=25^{\circ}\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	600	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=10V, I_D=9.6A$	-	-	115	m Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2	-	5	V
g_{fs}	Forward Transconductance	$V_{DS}=10V, I_D=14A$	-	21	-	S
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=480V, V_{GS}=0V$	-	-	100	μA
I_{GSS}	Gate-Source Leakage	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 1	μA
Q_g	Total Gate Charge	$I_D=14A$	-	91	145	nC
Q_{gs}	Gate-Source Charge	$V_{DS}=480V$	-	20	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$V_{GS}=10V$	-	42	-	nC
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=300V$	-	22	-	ns
t_r	Rise Time	$I_D=14A$	-	34	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=3.3\Omega$	-	89	-	ns
t_f	Fall Time	$V_{GS}=10V$	-	31	-	ns
C_{iss}	Input Capacitance	$V_{GS}=0V$	-	3200	5120	pF
C_{oss}	Output Capacitance	$V_{DS}=100V$	-	100	-	pF
C_{riss}	Reverse Transfer Capacitance	$f=1.0\text{MHz}$	-	7	-	pF
R_g	Gate Resistance	$f=1.0\text{MHz}$	-	4.2	8.4	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$I_S=9.6A, V_{GS}=0V$	-	0.85	-	V
t_{rr}	Reverse Recovery Time	$I_S=14A, V_{GS}=0V$	-	175	-	ns
Q_{rr}	Reverse Recovery Charge	$dI/dt=100A/\mu s$	-	1.7	-	μC

Notes:

1. Pulse width limited by max. junction temperature.
2. Pulse test
3. Limited by max. junction temperature. Maximum duty cycle $D=0.75$
4. Starting $T_j=25^{\circ}\text{C}$, $V_{DD}=90V$, $L=150\text{mH}$, $R_G=25\Omega$, $V_{GS}=10V$
5. $I_{SD} \leq I_D$, $V_{DD} \leq BV_{DSS}$, starting $T_j = 25^{\circ}\text{C}$

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

APEC RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN.

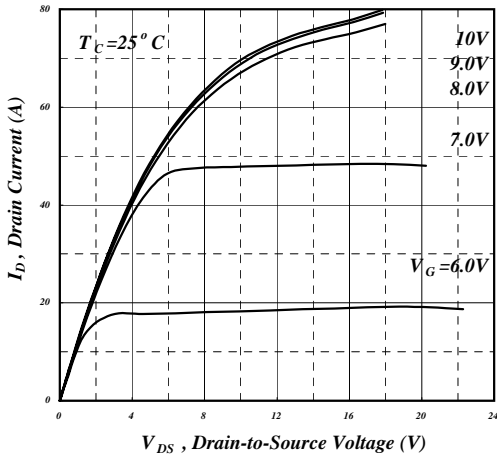


Fig 1. Typical Output Characteristics

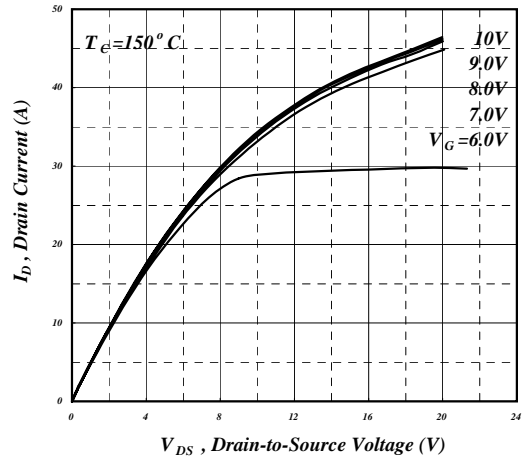


Fig 2. Typical Output Characteristics

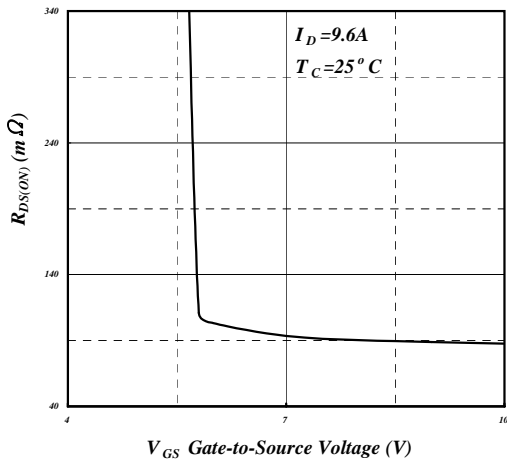


Fig 3. On-Resistance v.s. Gate Voltage

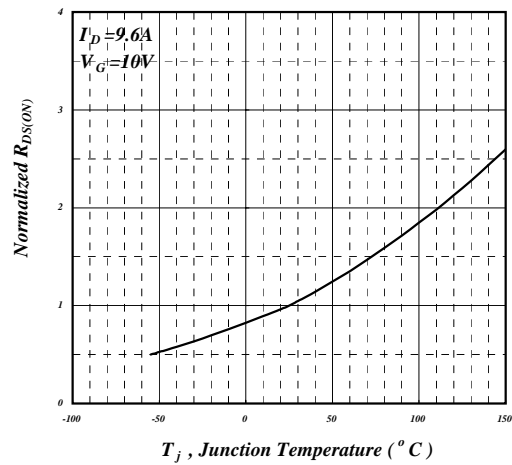


Fig 4. Normalized On-Resistance v.s. Junction Temperature

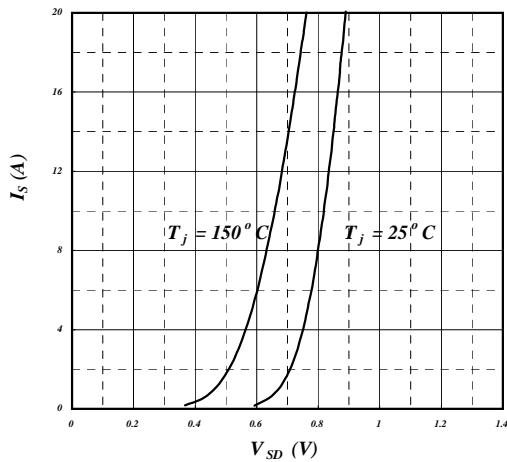


Fig 5. Forward Characteristic of Reverse Diode

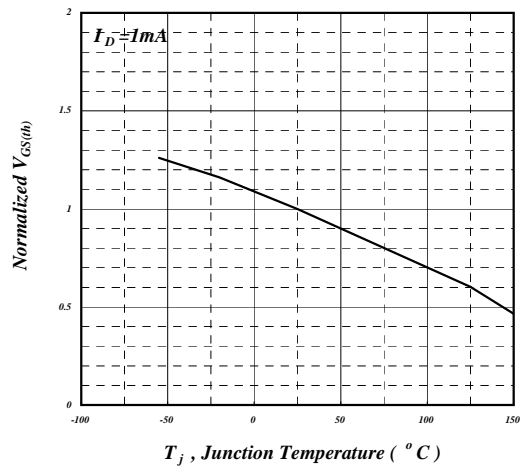


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

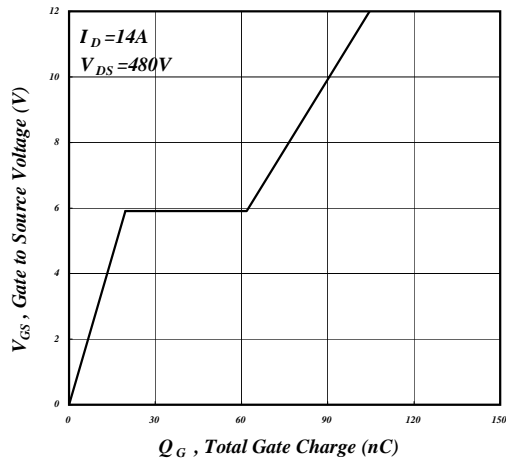


Fig 7. Gate Charge Characteristics

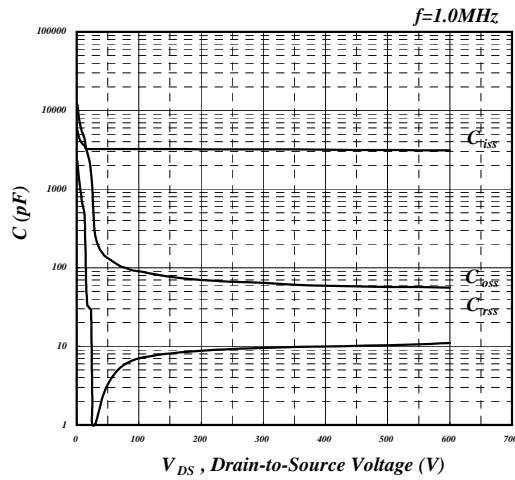


Fig 8. Typical Capacitance Characteristics

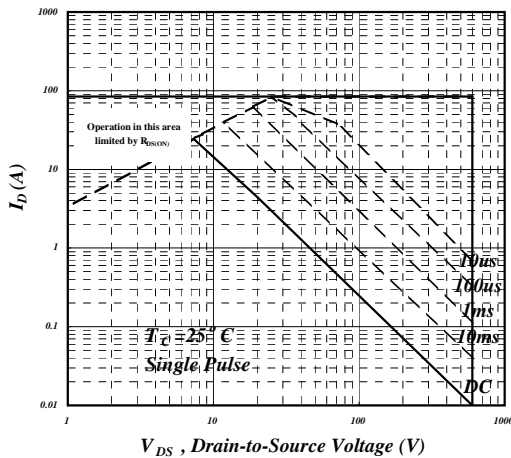


Fig 9. Maximum Safe Operating Area

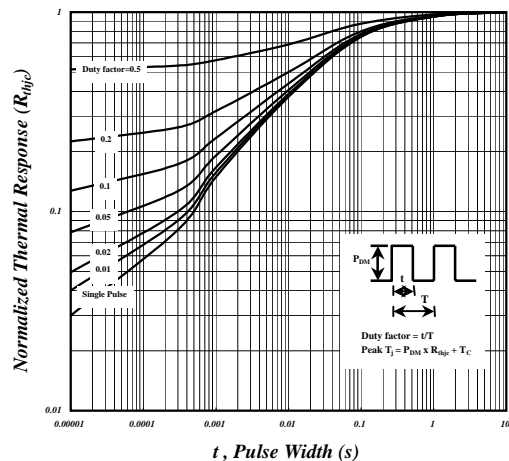


Fig 10. Effective Transient Thermal Impedance

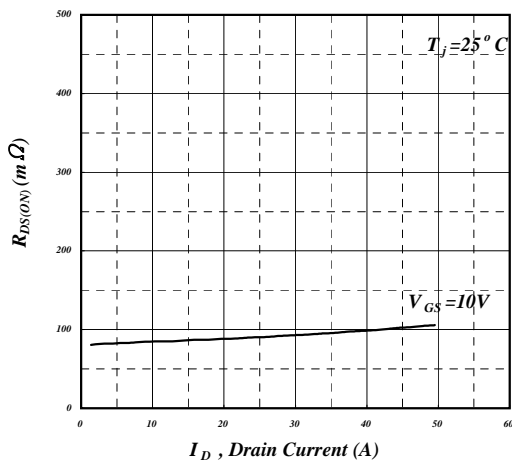


Fig 11. Typ. Drain-Source on State Resistance

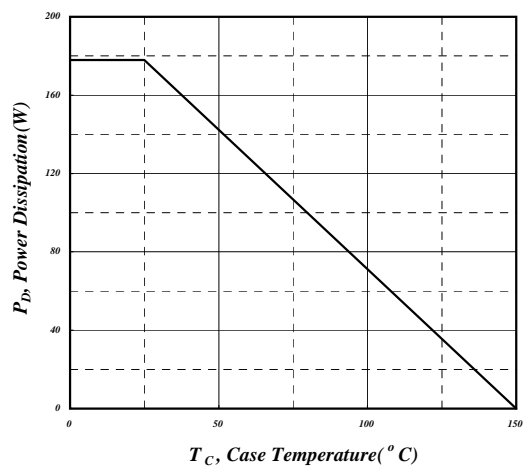
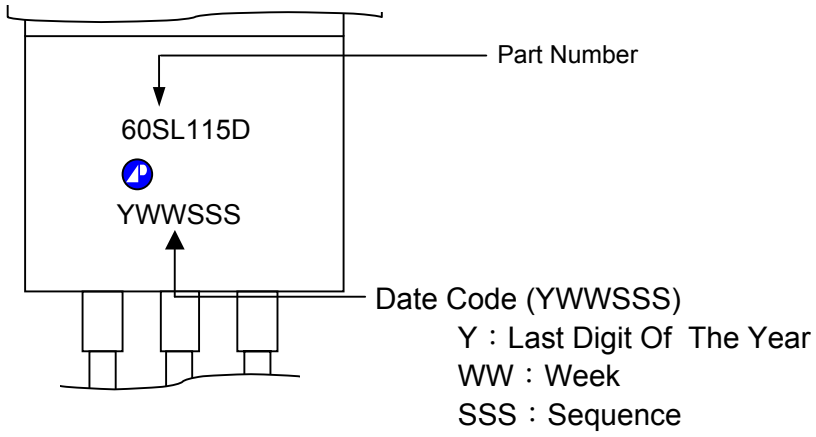


Fig 12. Total Power Dissipation

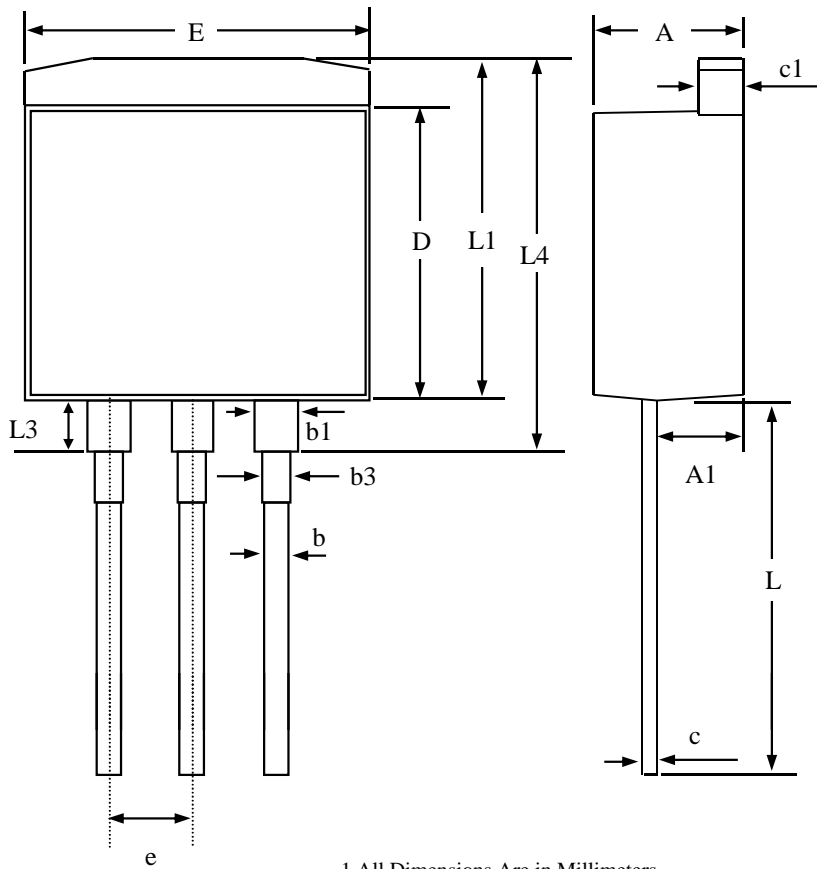


MARKING INFORMATION





Package Outline : TO-262



SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	4.24	4.54	4.84
A1	2.10	2.50	2.90
b	0.65	0.85	1.05
b1	0.63	1.08	1.53
b3	0.75	1.08	1.40
c	0.30	0.45	0.60
c1	1.15	1.3	1.45
D	8.30	8.9	9.50
E	9.50	10	10.50
e	2.04	2.54	3.04
L	10.50	12.5	14.50
L1	8.50	10	11.50
L3	1.3 ~ 4.8 (ref)		

- 1.All Dimensions Are in Millimeters.
- 2.Dimension Does Not Include Mold Protrusions.



TO-262 FOOTPRINT :

